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10/050,663	Reexamination YEH, ADAM E. C	<b>)</b> .			
Examiner	Art Unit				
Belix M. Ortiz	2175	Page 1 of 1			

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0099692	07-2002	Shah et al.	707/2
	В	US-2003/0115194	06-2003	Pitts et al.	707/3
	C	US-6,708,172	03-2004	Wong et al.	707/10
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	E	US-		•	
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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